

<b>Notice of References Cited</b>	Application/Control No. 10/522,270		Applicant(s)/Patent Under Reexamination LIEBHOLD ET AL.	
	Examiner Nnenna N. Ekpo		Art Unit 2623	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,446,080	09-2002	Van Ryzin et al.	707/104.1
*	B	US-2003/0023975	01-2003	Schrader et al.	725/51
*	C	US-2004/0148419	07-2004	Chen et al.	709/231
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	I	US-			
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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